


<b>Search Notes</b> 	<b>Application/Control No.</b> 10801207	<b>Applicant(s)/Patent Under Reexamination</b> CHANG ET AL.
	<b>Examiner</b> MARIA B MARVICH	<b>Art Unit</b> 1633

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
East, STN search updated, search notes attached	3/11/08	MM
East, STN search updated, search notes attached	1/2/08	MM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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